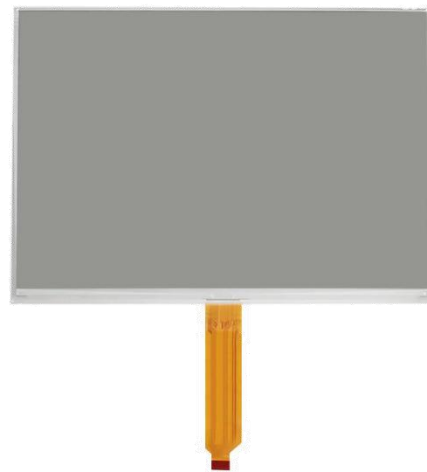


# 13.3inch e-Paper (K)

## User Manual



## Revision History

Version	Content	Date	Producer
1.0	Revision 1.0	2023/07/03	



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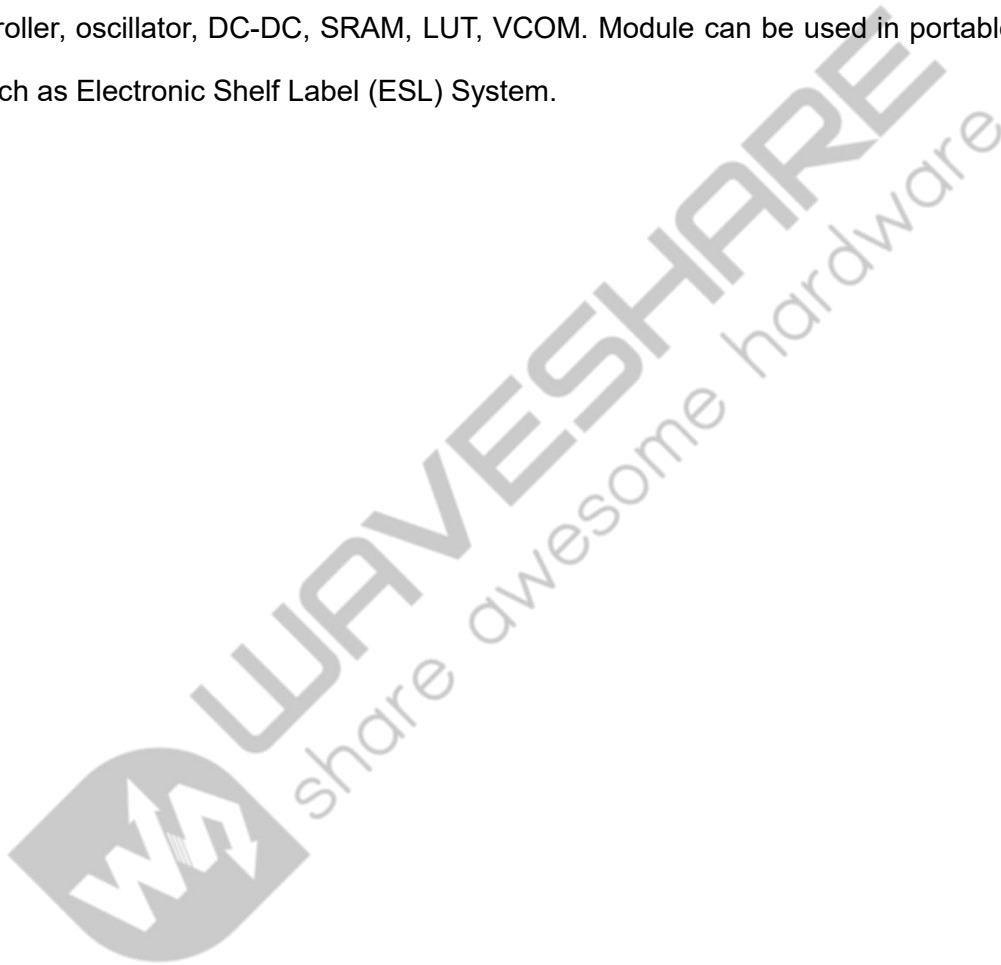
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## 1. OVERVIEW

13.3 e-Paper (K) is an Active Matrix Electrophoretic Display (AM EPD), with interface and a reference system design. The display is capable to display image at 1-bit white and black full display capabilities. The 13.3inch active area contains 960x680 pixels. The module is a TFT-array driving electrophoresis display, with integrated circuits including gate driver, source driver, MCU interface, timing controller, oscillator, DC-DC, SRAM, LUT, VCOM. Module can be used in portable electronic devices, such as Electronic Shelf Label (ESL) System.



## 2. FEATURES

- ✧ 960×680 pixels display
- ✧ High contrast High reflectance
- ✧ Ultra wide viewing angle Ultra low power consumption
- ✧ Pure reflective mode
- ✧ Bi-stable display
- ✧ Commercial temperature range
- ✧ Landscape portrait modes
- ✧ Hard-coat antiglare display surface
- ✧ Ultra Low current deep sleep mode
- ✧ On-chip display RAM
- ✧ Waveform can stored in On-chip OTP or written by MCU
- ✧ Serial peripheral interface available
- ✧ On-chip oscillator
- ✧ On-chip booster and regulator control for generating VCOM, Gate and Source driving voltage
- ✧ I<sup>2</sup>C signal master interface to read external temperature sensor
- ✧ Built-in temperature sensor

### 3. MECHANICAL SPECIFICATION

Parameter	Specification	Unit	Remark
Screen Size	13.3	Inch	
Display Resolution	960(H) x 680(V)	Pixel	DPI:88
Active Area	275.52 x 195.16	mm	
Pixel Pitch	0.287 x 0.287	mm	
Pixel Configuration	Rectangle		
Outline Dimension	286.32(H) x 212.26 (V) x 1.20(D)	mm	
Weight	106.7±0.5	g	

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit	Notes
KS	Back State L*value		-	18	20		3-1
	Back Ghosting ΔL		-	1	-		3-1
WS	White state L*value		66	67	-		3-1
	White Ghosting ΔL		-	1	-		3-1
R	White Reflectivity	White	30	34	-	%	3-1
CR	Contrast Ratio	Indoor	15:1	20:1	-		3-1
							3-2
GN	2 Grey Level	-	-	-	-		
Life		Temp:23±3°C Humidity: 55±10%RH		5 years	-		3-3

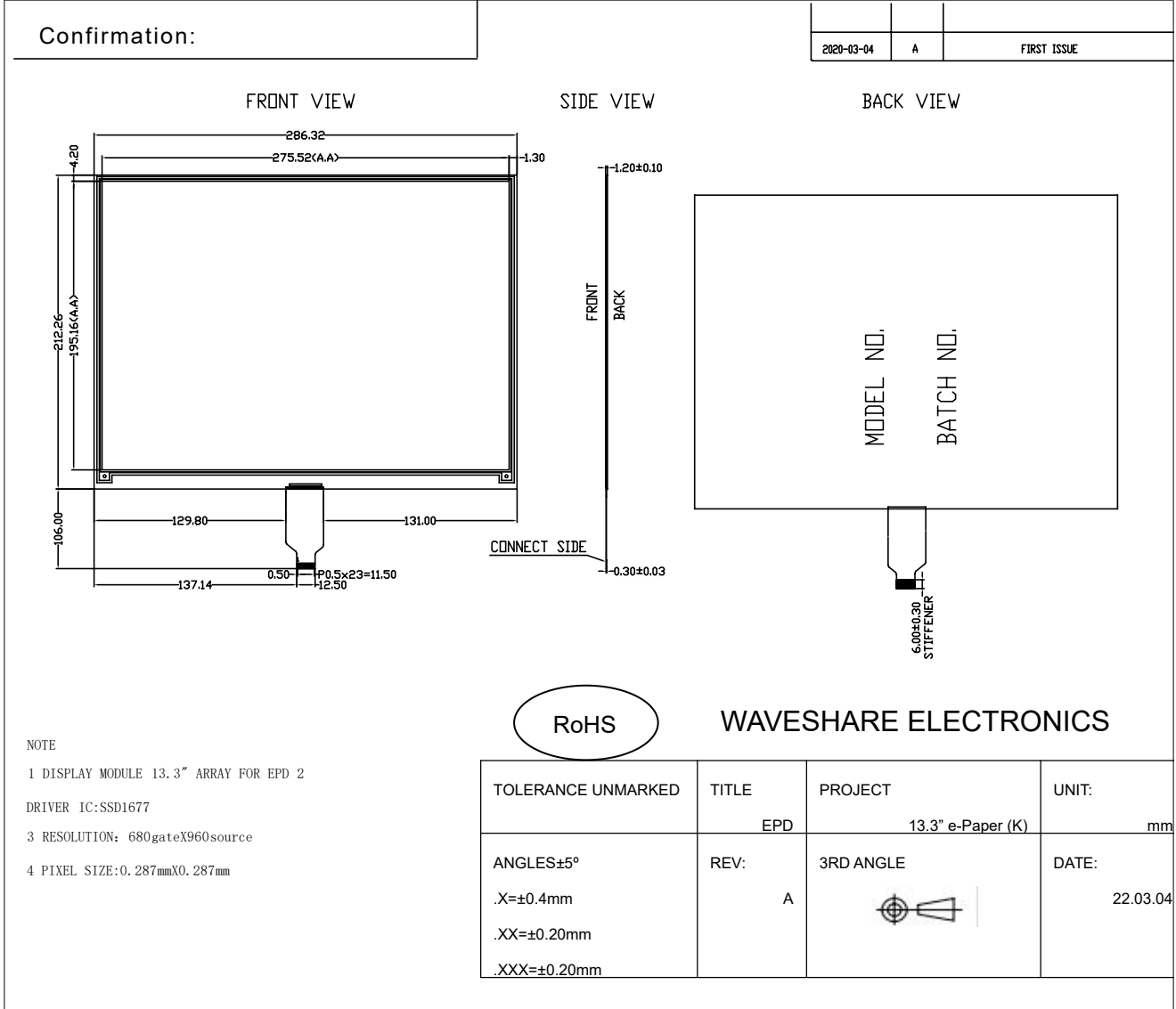
**Notes:**

**3-1. Luminance meter: Eye-One Pro Spectrophotometer.**

**3-2. CR=Surface Reflectance with all white pixel/Surface Reflectance with all black pixels.**

**3-3. When the product is stored. The display screen should be kept white and face up.**

## 4. MECHANICAL DRAWING OF EPD MODULE





## 5. INPUT/OUTPUT PIN ASSIGNMENT

I = Input Pin, O = Output Pin, I/O = Bidirectional Pin (Input/output), P = Power Pin, C = Capacitor Pin.

NO.	Name	I/O	Description	Remark
1	NC		Do not connect with other NPC pins	Keep Open
2	GDR	O	N-Channel MOSFET Gate Drive Control	
3	RESE	I	Current Sense Input for the Control Loop	
4	NC	NC	Do not connect with other NC pins	Keep Open
5	VSH	C	Positive Source driving voltage	
6	TSCL	O	I2C Interface to digital temperature sensor Clock pin	Note 5-6
7	TSDA	I/O	I2C Interface to digital temperature sensor Data pin	Note 5-6
8	BS1	I	Bus Interface selection pin	Note 5-5
9	BUSY	O	Busy state output pin	Note 5-4
10	RES#	I	Reset signal input, Active Low	Note 5-3
11	D/C#	I	Data/Command control pin	Note 5-2
12	CS#	I	Chip select output pin	Note 5-1
13	SCL	I	Serial Clock pin (SPI)	
14	SDA	I/O	Serial Data pin (SPI)	
15	VDDIO	P	Power supply for interface logic pins. It should be connected with VCI.	
16	VCI	P	Power supply for the chip	
17	VSS	P	Ground	
18	VDD	C	Core logic power pin VDD can be regulated internally from VCI. A capacitor should be connected between VDD and VSS.	
19	VPP	P	FOR TEST	Keep Open
20	VSH1	C	Positive Source driving voltage	
21	VGH	C	Power Supply pin for Positive Gate driving voltage and VSH1	
22	VSL	C	Negative Source driving voltage	
23	VGL	C	Power Supply pin for Negative Gate driving voltage VCOM and VSL	
24	VCOM	C	VCOM driving voltage	

**Note 5-1:** This pin (CS#) is the chip select input connecting to the MCU. The chip is enabled for MCU communication only when CS# is pulled LOW.

**Note 5-2:** This pin is (D/C#) Data/Command control pin connecting to the MCU in 4-wire SPI mode. When the pin is pulled HIGH, the data at SDA will be interpreted as data. When the pin is pulled LOW, the data at SDA will be interpreted as command.

**Note 5-3:** This pin (RES#) is reset signal input. The Reset is active low.

**Note 5-4:** This pin is Busy state output pin. When Busy is High, the operation of chip should not be interrupted, command should not be sent. The chip would put Busy pin High when  
-Outputting display waveform-Communicating with digital temperature sensor.

**Note 5-5:** Bus interface selection pin.

**Note 5-6:** The pin connects to the VSS if there is no external temperature sensor.

BS1 State	MCU Interface
L	4-lines serial peripheral interface(SPI) - 8 bits SPI
H	3- lines serial peripheral interface(SPI) - 9 bits SPI

## 6. COMMAND TABLE

R/W#	D/C#	Hex	D7	D6	D5	D4	D3	D2	D1	D0	Command	Description						
0	0	01	0	0	0	0	0	0	0	1	Driver Output Control	Gate setting						
0	1		A7	A6	A5	A4	A3	A2	A1	A0		Set A[9:0]=2A7h[POR]						
0	1		0	0	0	0	0	0	0	A8		680MUX						
0	1		0	0	0	0	0	B2	B1	B0		Set B[2:0]=000[POR]						
0	0	03	0	0	0	0	0	0	1	1	Gate Driving voltage control	Set Gate Driving voltage						
0	1		0	0	0	A4	A3	A2	A1	A0		A[4:0] = 17h[POR], VGH at 20V[POR] VGH setting from 12V to 20V						
0	0	04	0	0	0	0	0	1	0	0	Source Driving voltage control	Set Source Driving voltage						
0	1		A7	A6	A5	A4	A3	A2	A1	A0		A[7:0] = 41h[POR], VSH1 at 15V						
0	1		B7	B6	B5	B4	B3	B2	B1	B0		B[7:0]=A8h[POR], VSH2 at 5.0V						
0	1		C7	C6	C5	C4	C3	C2	C1	C0		C[7:0]=32h[POR], VSL1 at -15V						
0	0	10	0	0	0	1	0	0	0	0	Deep Sleep mode	Deep Sleep mode Control						
0	1		0	0	0	0	0	0	A1	A0		<table border="1"> <thead> <tr> <th>A[1:0]:</th> <th>Description</th> </tr> </thead> <tbody> <tr> <td>00</td> <td>Normal Mode [POR]</td> </tr> <tr> <td>11</td> <td>Enter Deep Sleep Mode</td> </tr> </tbody> </table>	A[1:0]:	Description	00	Normal Mode [POR]	11	Enter Deep Sleep Mode
A[1:0]:	Description																	
00	Normal Mode [POR]																	
11	Enter Deep Sleep Mode																	
After this command initiated, the chip will enter Deep Sleep Mode, BUSY pad will keep output high.																		
0	0	11	0	0	0	1	0	0	0	1	Data Entry mode setting	Define data entry						
0	1		0	0	0	0	0	A2	A1	A0		sequence A[1:0]=ID[1:0] Address automatic increment / decrement setting The setting of incrementing or decrementing of the address counter can be made independently in each upper and lower bit of the address.						

												00 –Y decrement, X decrement, 01 –Y decrement, X increment, 10 –Y increment, X decrement, 11 –Y increment, X increment [POR] A[2] = AM Set the direction in which the address counter is updated automatically after data are written to the RAM. AM=0, the address counter is updated in the X direction. [POR] AM=1, the address counter is updated in the Y direction.
0	0	12	0	0	0	1	0	0	1	0		SWRESET It resets the commands and parameters to their S/W Reset default values except R10h-Deep Sleep Mode. During operation, BUSY pad will output high. Note: RAM are affected by this command.
0	0	18	0	0	0	1	1	0	0	0		Temperature Sensor Control Temperature Sensor Selection A[7:0]=48h [POR], external temperature sensor A[7:0]=80h [POR], internal temperature sensor
0	1		A7	A6	A5	A4	A3	A2	A1	A0		
0	0	1A	0	0	0	1	1	0	1	0		Temperature Sensor Control (Write to temperature register. A[11:0]=7FFh[POR]
0	1		A11	A10	A9	A8	A7	A6	A5	A4		
0	1		A3	A2	A1	A0	0	0	0	0		

											register)													
0	0	20	0	0	1	0	0	0	0	0	Master Activation	Active Display Update Sequence The Display Update Sequence Option is located at R22h. User should not interrupt this operation to avoid corruption of panel images												
0	0	21	0	0	1	0	0	0	0	1														
0	1		A7	A6	A5	A4	A3	A2	A1	A0	Display Update Control 1	RAM content option for Display Update A[7:0]=00H[POR] A[7:4] Red RAM option <table border="1"> <tr><td>0000</td><td>Normal</td></tr> <tr><td>0100</td><td>Bypass RAM content as 0</td></tr> <tr><td>1000</td><td>Inverse RAM content</td></tr> </table> A[3:0] BW RAM option <table border="1"> <tr><td>0000</td><td>Normal</td></tr> <tr><td>0100</td><td>Bypass RAM content as 0</td></tr> <tr><td>1000</td><td>Inverse RAM content</td></tr> </table>	0000	Normal	0100	Bypass RAM content as 0	1000	Inverse RAM content	0000	Normal	0100	Bypass RAM content as 0	1000	Inverse RAM content
0000	Normal																							
0100	Bypass RAM content as 0																							
1000	Inverse RAM content																							
0000	Normal																							
0100	Bypass RAM content as 0																							
1000	Inverse RAM content																							
0	0	22	0	0	1	0	0	0	1	0														
	1		A7	A6	A5	A4	A3	A2	A1	A0	Display Update Control 2	Display Update Sequence Option: Enable the stage or Master Activation <table border="1"> <tr><td colspan="2"><b>Setting for LUT from MCU</b></td></tr> <tr><td>Enable Clock Signal, Then Enable Analog Then PATTERN DISPLAY Then Disable Analog Then Disable OSC</td><td rowspan="2">C7</td></tr> <tr><td colspan="2"><b>Setting for LUT from</b></td></tr> </table>	<b>Setting for LUT from MCU</b>		Enable Clock Signal, Then Enable Analog Then PATTERN DISPLAY Then Disable Analog Then Disable OSC	C7	<b>Setting for LUT from</b>							
<b>Setting for LUT from MCU</b>																								
Enable Clock Signal, Then Enable Analog Then PATTERN DISPLAY Then Disable Analog Then Disable OSC	C7																							
<b>Setting for LUT from</b>																								



1	1		C7	C6	C5	C4	C3	C2	C1	C0	Information 2. C[7:0]~G[7:0]: Display mode 3. H[7:0]~K[7:0]: Waveform Version [4bytes]	
1	1		D7	D6	D5	D4	D3	D2	D1	D0		
1	1		E7	E6	E5	E4	E3	E2	E1	E0		
1	1		F7	F6	F5	F4	F3	F2	F1	F0		
1	1		G7	G6	G5	G4	G3	G2	G1	G0		
1	1		H7	H6	H5	H4	H3	H2	H1	H0		
1	1		I7	I6	I5	I4	I3	I2	I1	I0		
1	1		J7	J6	J5	J4	J3	J2	J1	J0		
1	1		K7	K6	K5	K4	K3	K2	K1	K0		
0	0	2F	0	0	1	0	1	1	1	1		
1	1		0	0	A5	A4	A3	A2	A1	A0	Status Bit Read Read IC status Bit [POR 0x21] A[5]: HV relay detection flag [POR=1] 0: Ready 1: Not ready A[4]: VCI detection flag [POR=0] 0: Normal 1: VCI lower than the Detect level A[3]: [POR=0] 0: Normal 1: BUSY A[1:0]: Chip ID [POR=0] Remark: A[5] and A[4] status are not valid after RESET, they need to be initiated by command 0x14 and command 0x15 respectively.	
0	0	32	0	0	1	1	0	0	1	0		
0	1		A7	A6	A5	A4	A3	A2	A1	A0		
0	1		B7	B6	B5	B4	B3	B2	B1	B0		
0	1		:	:	:	:	:	:	:	:		
0	1		:	:	:	:	:	:	:	:		
0	0	3A	0	0	1	1	1	0	1	0	Reserved	Reserved
0	0	3B	0	0	1	1	1	0	1	1	Reserved	Reserved
0	0	3C	0	0	1	1	1	1	0	0	Border	Select boarder waveform for VBD
0	1		A7	A6	A5	A4	0	0	A1	A0	Waveform Control	A[7:0]=C0h [POR], set







## 7. ELECTRICAL CHARACTERISTICS

### 7.1 ABSOLUTE MAXIMUM RATING

Parameter	Symbol	Rating	Unit
Logic supply voltage	VCI	-0.3 to +6.0	V
Logic Input voltage	VIN	-0.3 to VCI +0.3	V
Operating Temp range	TOPR	0 to +50	°C
Storage Temp range	TSTG	-25 to+70	°C
Optimal Storage Temp	TSTGo	23±3	°C
Optimal Storage Humidity	HSTGo	55±10	%RH

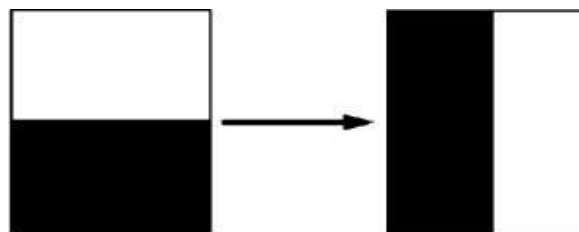
**Note:** Maximum ratings are those values beyond which damages to the device may occur. Functional operation should be restricted to the limits in the Panel DC Characteristics tables.

## 7.2 PANEL DC CHARACTERISTICS

The following specifications apply for: VSS=0V, VCI=3.0V, TOPR =23°C.

Parameter	Symbol	Condition	Applicable pin	Min.	Typ.	Max.	Unit
Single ground	V <sub>SS</sub>	-		-	0	-	V
Logic supply voltage	V <sub>CI</sub>	-	V <sub>CI</sub>	2.2	3.0	3.3	V
Core logic voltage	V <sub>DD</sub>		V <sub>DD</sub>	1.7	1.8	1.9	V
High level input voltage	V <sub>IH</sub>	-	-	0.8V <sub>CI</sub>	-	-	V
Low level input voltage	V <sub>IL</sub>	-	-	-	-	0.2V <sub>CI</sub>	V
High level output voltage	V <sub>OH</sub>	I <sub>OH</sub> = - 100uA	-	0.9V <sub>CI</sub>	-	-	V
Low level output voltage	V <sub>OL</sub>	I <sub>OL</sub> = 100uA	-	-	-	0.1V <sub>CI</sub>	V
Typical power	P <sub>TYP</sub>	V <sub>CI</sub> =3.0V	-	-	66	-	mW
Deep sleep mode	P <sub>STPY</sub>	V <sub>CI</sub> =3.0V	-	-	0.009	-	mW
Typical operating current	I <sub>opr_VCI</sub>	V <sub>CI</sub> =3.0V	-	-	22	-	mA
Image update time	-	23 °C	-	-	4	-	sec
Typical peak current	I <sub>opr_VCI</sub>	2.2~3.7v			100	160	mA
Sleep mode current	I <sub>slp_VCI</sub>	DC/DC off, No clock No input load Ram data retain	-	-	20	-	uA
Deep sleep mode current	I <sub>dslp_VCI</sub>	DC/DC off, No clock No input load Ram data not retain	-	-	3	5	uA

**Notes: 1. The typical power is measured with following transition from horizontal 2 scale pattern to vertical.**



2. The deep sleep power is the consumed power when the panel controller is in deep sleep mode.
3. The listed electrical characteristics are only guaranteed under the controller & waveform provided by Waveshare.
4. Electrical measurement: Tektronix oscilloscope - MDO3024, Tektronix current probe –TCP0030A.

### 7.3 PANEL DC CHARACTERISTICS (DRIVER IC INTERNAL REGULATORS)

The following specifications apply for: VSS=0V, VCI=3.0V, TOPR=23°C.

Parameter	Symbol	Condition	Applicable pin	Min.	Typ.	Max.	Unit
VCOM output voltage	VCOM	-	VCOM	-	TBD	-	V
Positive Source output voltage	V <sub>SH</sub>	-	S <sub>0</sub> ~S <sub>959</sub>	+14.8	+15	+15.2	V
Negative Source output voltage	V <sub>SL</sub>	-	S <sub>0</sub> ~S <sub>959</sub>	-15.2	-15	-14.8	V
Positive gate output voltage	V <sub>gh</sub>	-	G <sub>0</sub> ~G <sub>679</sub>	+19.5	+20	+20.5	V
Negative gate output voltage	V <sub>gl</sub>	-	G <sub>0</sub> ~G <sub>679</sub>	-20.5	-20	-19.5	V

## 7.4 MCU INTERFACE

### 7.4.1 MCU INTERFACE SELECTION

The pin assignment at different interface mode is summarized in Table 7-4-1. Different MCU mode can be set by hardware selection on BS1 pins. The display panel only supports 4-wire SPI or 3-wire SPI interface mode.

Pin Name	Data/Command Interface		Control Signal		
	SDA	SCL	CS#	D/C#	RES#
Bus interface	SDA	SCL	CS#	D/C#	RES#
BS1=L 4-wire SPI	SDA	SCL	CS#	D/C#	RES#
BS1=H 3-wire SPI	SDA	SCL	CS#	D/C#	RES#

### 7.4.2 MCU SERIAL INTERFACE (4-WIRE SPI)

The serial interface consists of serial clock SCL, serial data SDA, D/C#, CS#. This interface supports Write mode and Read mode.

Function	CS#	D/C#	SCL
Write command	L	L	↑
Write data	L	H	↑

**Note:** ↑ stands for rising edge of signal.

In the write mode SDA is shifted into an 8-bit shift register on every rising edge of SCL in the order of D7, D6, ... D0. The level of D/C# should be kept over the whole byte. The data byte in the shift register is written to the Graphic Display Data RAM/Data Byte register or command Byte register according to D/C# pin.

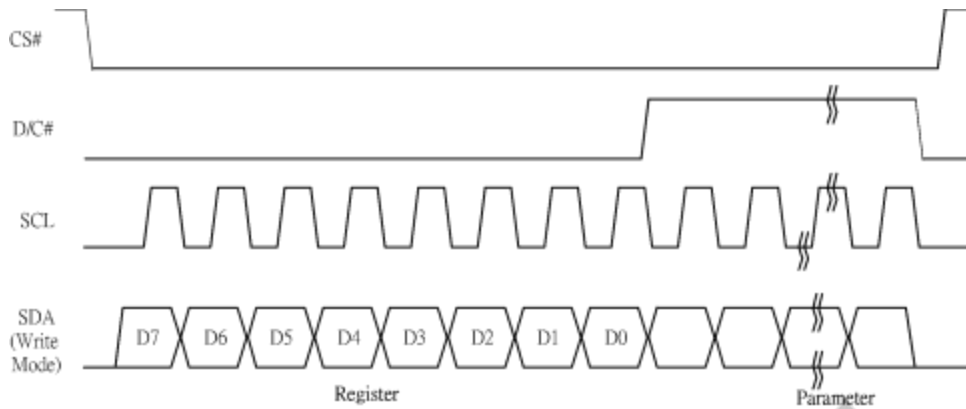


Figure 7-1: Write procedure in 4-wire SPI mode

In the Read mode:

1. After driving CS# to low, MCU need to define the register to be read.
2. SDA is shifted into an 8-bit shift register on every rising edge of SCL in the order of D7, D6, ... D0 with D/C# keep low.
3. After SCL change to low for the last bit of register, D/C# need to drive to high.
4. SDA is shifted out an 8-bit data on every falling edge of SCL in the order of D7, D6, ... D0.
5. Depending on register type, more than 1 byte can be read out. After all byte are read, CS# need to drive to high to stop the read operation.

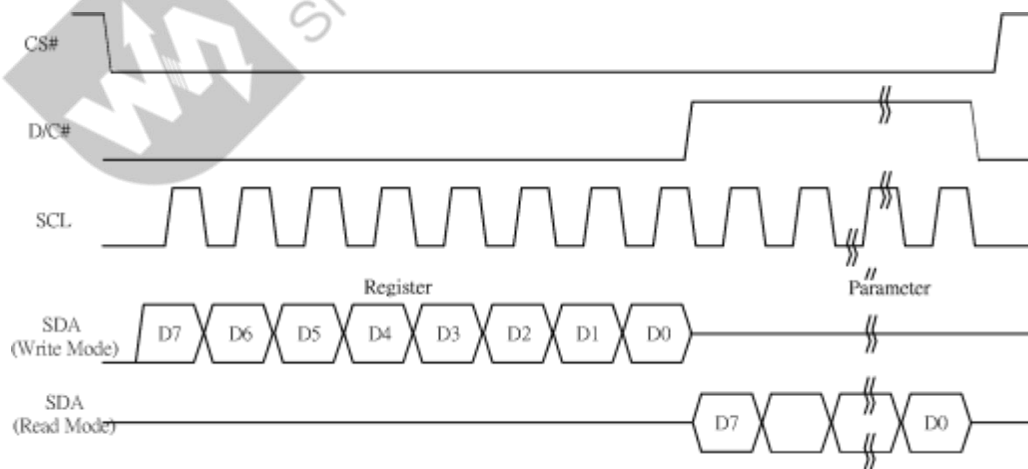


Figure 7-2: Read procedure in 4-wire SPI mode

7.4.3 MCU SERIAL INTERFACE (3-WIRE SPI)

The 3-wire serial interface consists of serial clock SCL, serial data SDA and CS#. This interface also supports Write mode and Read mode.

The operation is similar to 4-wire serial interface while D/C# pin is not used. There are altogether 9-bits will be shifted into the shift register on every ninth clock in sequence: D/C# bit, D7 to D0 bit. The D/C# bit (first bit of the sequential data) will determine the following data byte in the shift register is written to the Display Data RAM (D/C# bit=1) or the command register (D/C# bit=0).

Function	CS#	D/C#	SCL
Write command	L	Tie	↑
Write data	L	Tie	↑

Note: ↑ stands for rising edge of signal

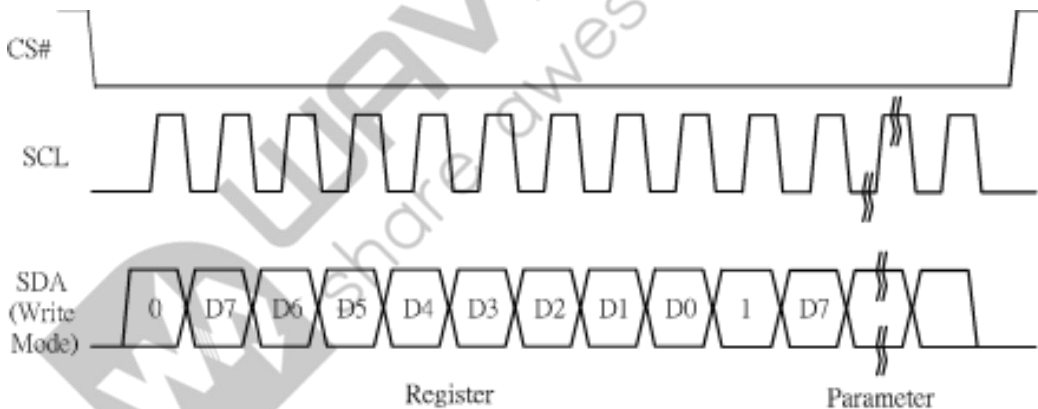


Figure 7-3: Write procedure in 3-wire SPI mode

In the Read mode:

1. After driving CS# to low, MCU need to define the register to be read.
2. D/C=0 is shifted thru SDA with one rising edge of SCL.
3. SDA is shifted into an 8-bit shift register on every rising edge of SCL in the order of D7, D6, ...

D0.

4. D/C=1 is shifted thru SDA with one rising edge of SCL.
5. SDA is shifted out an 8-bit data on every falling edge of SCL in the order of D7, D6, ... D0.
6. Depending on register type, more than 1 byte can be read out. After all byte are read, CS# need to drive to high to stop the read operation.

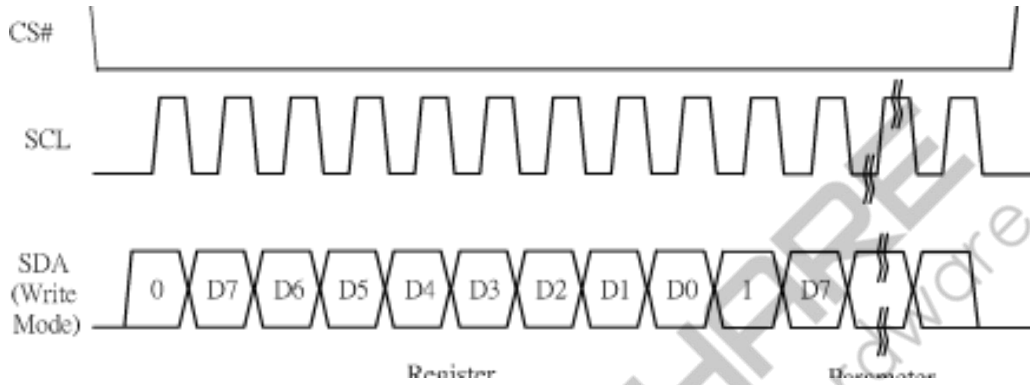
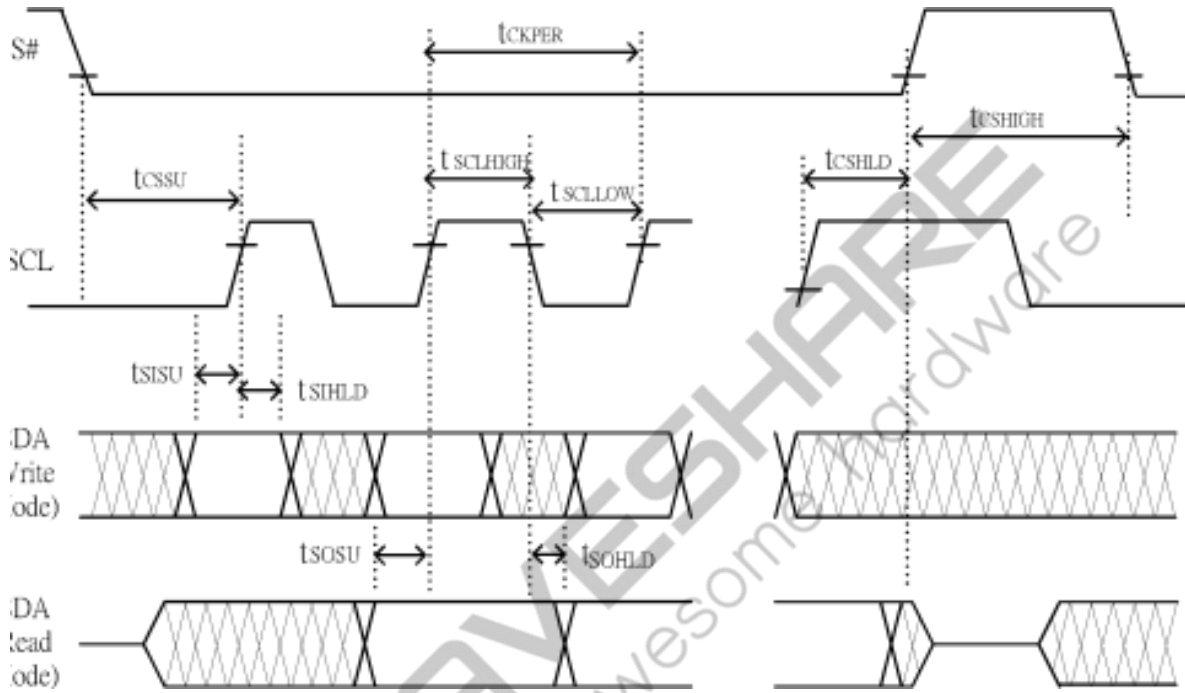


Figure 7-4: Read procedure in 3-wire SPI mode



#### 7.4.4 INTERFACE TIMING

The following specifications apply for: VSS=0V, VCI=3.0V, TOPR =23°C.



Changed diagram

#### Serial Interface Timing Characteristics

(VCI - VSS = 2.2V to 3.7V, TOPR = 23°C, CL=20pF)

### Write mode

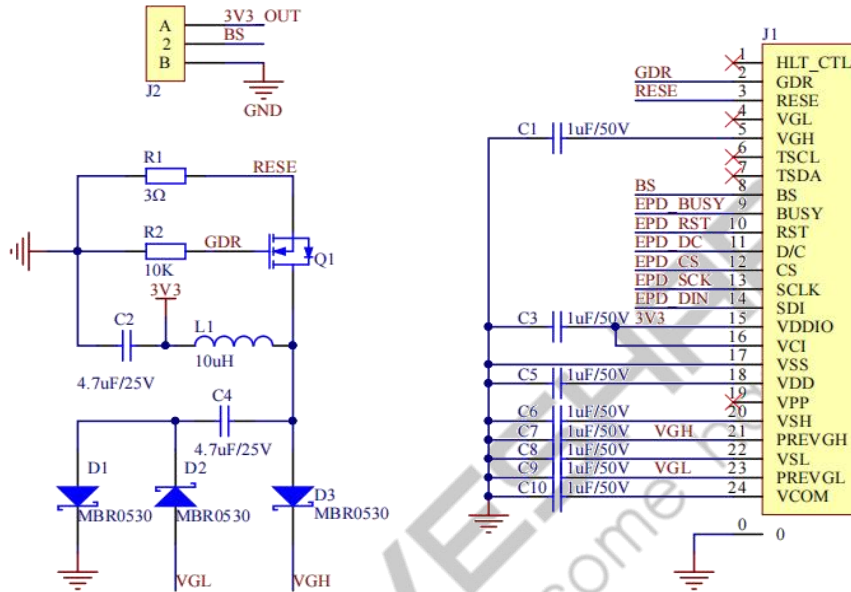
Symbol	Parameter	Min.	Typ.	Max.	Unit
fSCL	SCL frequency (Write Mode)			20	MHZ
tCSSU	Time CS# has to be low before the first rising edge of SCLK	60			ns
tCSHLD	Time CS# has to remain low after the last falling edge of SCLK	65			ns
tCSHIGH	Time CS# has to remain high between two transfers	100			ns
tSCLHIGH	Part of the clock period where SCL has to remain high	25			ns
tSCLLOW	Part of the clock period where SCL has to remain low	25			ns
tSISU	Time SI (SDA Write Mode) has to be stable before the next rising edge of SCL	10			ns
tSIHLD	Time SI (SDA Write Mode) has to be stable before the next rising edge of SCL	40			ns

### Read mode

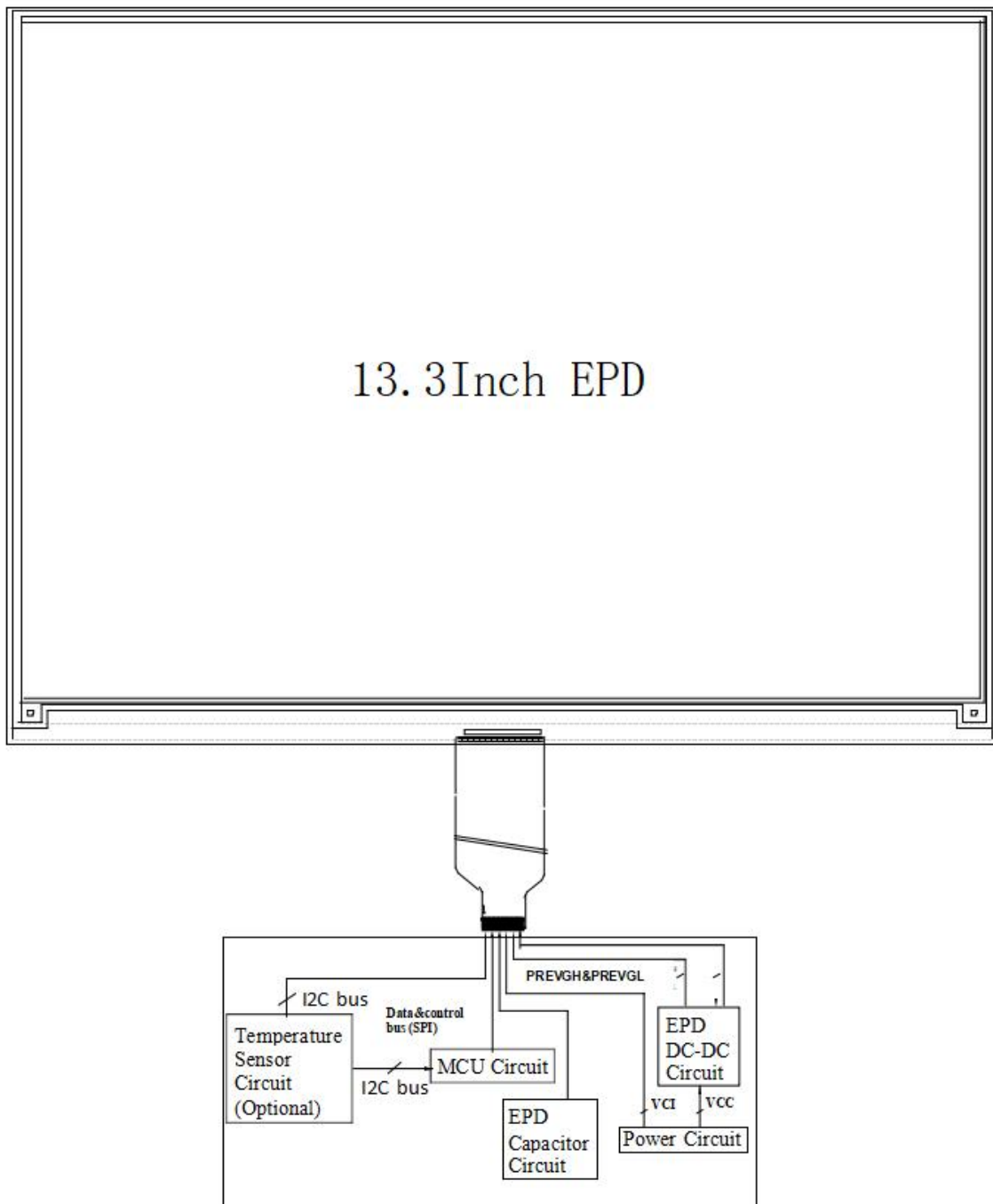
Symbol	Parameter	Min.	Typ.	Max.	Unit
fSCL	SCL frequency (Read Mode)			2.5	MHZ
tCSSU	Time CS# has to be low before the first rising edge of SCLK	100			ns
tCSHLD	Time CS# has to remain low after the last falling edge of SCLK	50			ns
tCSHIGH	Time CS# has to remain high between two transfers	250			ns
tSCLHIGH	Part of the clock period where SCL has to remain high	180			ns
tSCLLOW	Part of the clock period where SCL has to remain low	180			ns
tSOSU	Time SI (SDA Read Mode) has to be stable before the next rising edge of SCL		50		ns
tSOHLD	Time SO (SDA Read Mode) has to be stable before the next rising edge of SCL		0		ns

7.5 REFERENCE CIRCUIT

BS	VCC	GND
Interface	3-line SPI	4-line SPI



## 8. BLOCK DIAGRAM



## 9. MATCHED DEVELOPMENT KIT

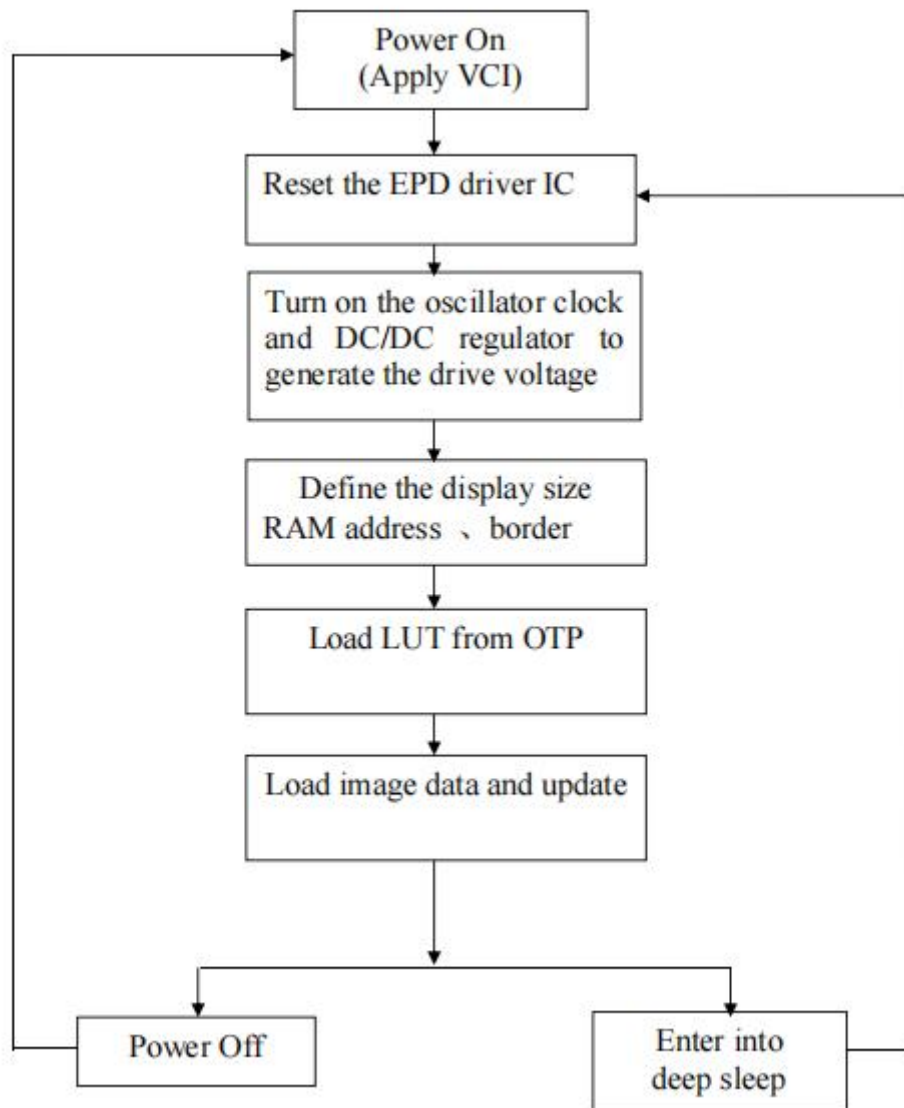
Our Development Kit designed for SPI e-Paper Display aims to help users to learn how to use e-Paper Display more easily. It can refresh black-white Display, three-color (black, white and red/yellow) e-Paper Display, four-color (black, white, red and yellow) Waveshare's e-Paper Display.

Development Kit consists of the development board and the pinboard. Supported development platforms include Raspberry Pi, STM32, Arduino UNO, etc. For more details, please click to the following link: <https://www.waveshare.com/product/displays.htm>



## 10. TYPICAL OPERATING STATUS

### 10.1 LUT FROM OTP OPERATION FLOW



**10.2 OTP OPERATION REFERENCE PROGRAM CODE**

<b>ACTION</b>	<b>VALUE/DATA</b>	<b>COMMENT</b>
<b>POWER ON</b>		
delay	10ms	
<b>PIN CONFIG</b>		
RESE#	low	Hardware reset
delay	200us	
RESE#	high	
delay	200us	
Read busy pin		Wait for busy low
Command 0x12		Software reset
Read busy pin		Wait for busy low
<b>LOAD LUT</b>		
Command 0x18	Data 0x80	Set built-in temperature sensor
Command 0x22	Data 0xB1	Load LUT
Command 0x20		
Read busy pin		Wait for busy low
<b>LOAD IMAGE AND UPDATE</b>		
Command 0x24	81600bytes	Load BW image (960/8*680)
Command 0x22	Data 0xC7	Image update
Command 0x20		
Read busy pin		Wait for busy low
Command 0x10	Data 0x01	Enter deep sleep mode
<b>POWER OFF</b>		

## 11. RELIABILITY TEST

NO	Test items	Test condition
1	Low-Temperature Storage	T = -25°C, 240 h Test in white pattern
2	High-Temperature Storage	T=+70°C, RH=40%, 240h Test in white pattern
3	High-Temperature Operation	T=+50°C, RH=30%, 240h
4	Low-Temperature Operation	0°C, 240h
5	High Temperature High Humidity Operation	T=40°C , RH=90%, 240h
6	High Temperature High Humidity Storage	T=60°C , RH=80%, 240h Test in white pattern
6	Temperature Cycle	1 cycle: [-25°C 30min]→ [+70 °C 30 min] : 100 cycles Test in white pattern
7	ESD Gun	Air+/-4KV; Contact +/-2KV Contact +/-2KV (HBM C:100pF; R:1.5k ohm) Contact +/-200V (MM C:2000pF; R:0 ohm) (Naked EPD display, including IC and FPC area)

**Note:** 1. Stay white pattern for storage and non-operation test.

2. Operation is black →white pattern, the interval is 150s.



## 12. QUALITY ASSURANCE

### 12.1 ENVIRONMENT

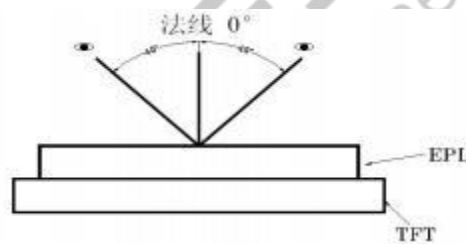
Temperature:  $23\pm 3^{\circ}\text{C}$

Humidity:  $55\pm 10\%\text{RH}$

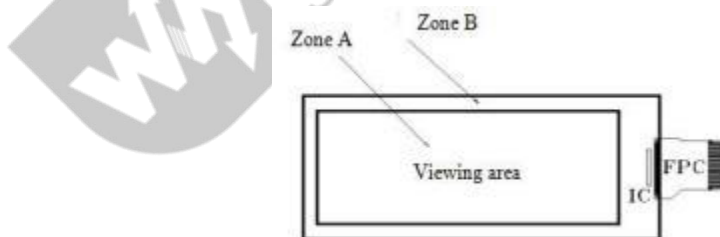
### 12.2 ILLUMINANCE

Brightness: 1200~1500LUX; distance: 20-30CM; Angle: Relate  $45^{\circ}$  surround.

### 12.3 INSPECT METHOD



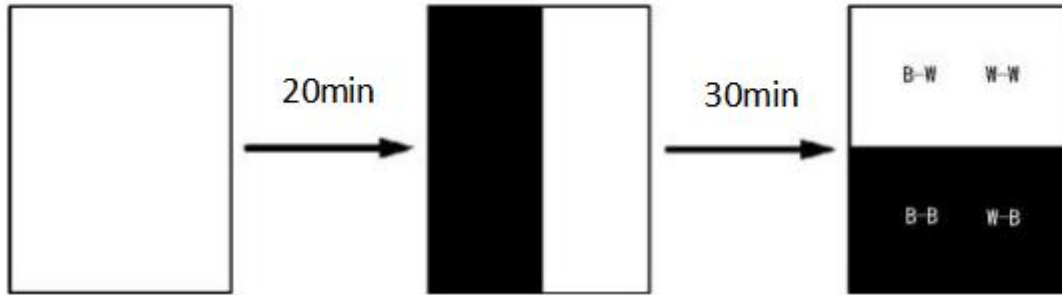
### 12.4 DISPLAY AREA



### 12.5 GHOSTING TEST METHOD

Two-color ghosting is measured with following transition from horizontal 2 scale pattern to vertical 2 scale pattern.

The listed optical characteristics are only guaranteed under the controller & waveform provided by Waveshare.



1) Measurement Instruments: X-rite i1Pro

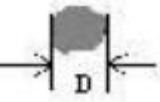
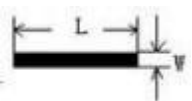
2) Ghosting formula:

W ghosting:  $\Delta L = \text{Max} (\Delta L(W-W, B-W)) - \text{Min} (\Delta L(W-W, B-W))$

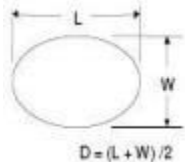


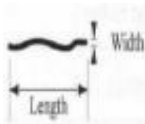


K ghosting:  $\Delta L = \text{Max} (\Delta L(W-B, B-B)) - \text{Min} (\Delta L(W-B, B-B))$

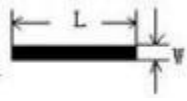

## 12.6 INSPECTION STANDARD

### 12.6.1 ELECTRIC INSPECTION STANDARD

NO.	Item	Standard	Defect level	Method	Scope		
1	Display	Clear display Display complete Display uniform	MA	Visual inspection  Visual/ Inspection card	Zone A		
2	Black/White spots	 D≤0.3mm, negligible 0.3mm<D≤0.5mm, N≤7, Allowed 0.5mm<D≤0.6mm, N≤1, Allowed 0.6mm<D, Not allow	MI				
3	Black/White spots (No switch)	 L ≤1mm, W≤0.15mm negligible 1.0mm<L ≤4.0mm 0.15mm<W≤0.5mm N≤4 Allow L>4.0mm, W>0.5mm, Not allow					
4	Ghost image	Allowed in switching process	MI				
5	Flash dot/Multilateral	Flash points are allowed when switching screens Multilateral colors outside the frame are allowed for fixed screen time	MI			Zone A Zone B	
6	Segment display	Selection segment are all displayed, and other segments are not displayed after the selection segment	MA			Visual inspection	Zone A
7	Short circuit/Circuit break/Abnormal display	Not Allowed					

12.6.2 APPEARANCE INSPECTION STANDARD

NO.	Item	Standard	Defect level	Method	Scope
1	B/W spots/Bubble/Foreign bodies/Dents	 <p><math>D = (L + W) / 2</math></p> <p>D≤0.3mm, negligible 0.3mm&lt;D≤0.5mm, N≤7, Allowed 0.5mm&lt;D≤0.6mm, N≤1, Allowed D&gt;0.6mm, Not allow</p>	MI	Visual Inspection	Zone A
2	Glass crack	Not Allowed	MA	Visual/ Microscope	Zone A Zone B
3	Dirty	Allowed if can be removed	MI		Zone A Zone B
4	Chips/Scratch/Edge crown	 <p><math>X \leq 3\text{mm}, Y \leq 0.5\text{mm}</math></p>  <p><math>2\text{mm} \leq X</math> or <math>2\text{mm} \leq Y</math> Allow</p>  <p><math>W \leq 0.1\text{mm}, L \leq 5\text{mm}, n \leq 2</math></p>	MI	Visual/ Microscope	Zone A Zone B
5	TFT Cracks	 <p>Not allow</p>	MA	Visual/ Microscope	Zone A Zone B
6	Dirty/Foreign body	Allowed if can be removed/allow	MI	Visual/ Microscope	Zone A /Zone B
7	FPC broken/FPC Oxidation/scratch	 <p>Not allow</p>	MA	Visual/ Microscope	Zone B

8	B/W Line	 <p><math>L \leq 1.0\text{mm}</math>, <math>W \leq 0.15\text{mm}</math> negligible  <math>1\text{mm} &lt; L \leq 4.0\text{mm}</math>  <math>0.15\text{mm} &lt; W \leq 0.5\text{mm}</math>, <math>N \leq 4</math> Allow  <math>L &gt; 4.0\text{mm}</math>, <math>W &gt; 0.5\text{mm}</math>, Not allow</p>	MI	Visual/Ruler	Zone B
9	TFT edge bulge/TFT chromatic aberration	TFT edge bulge: $X \leq 3\text{mm}$ , $Y \leq 0.3\text{mm}$ ; Allowed TFT chromatic aberration; Allowed	MI	Visual/ Microscope	Zone A Zone B
10	Electrostatic point	$D \leq 0.3\text{mm}$ , negligible $0.5\text{mm} < D \leq 0.5\text{mm}$ $n \leq 4$ Allow $D > 0.5\text{mm}$ Not allow ( $n \leq 10$ items are allowed within 5mm in diameter)	MI	Visual/ Microscope	Zone A
11	PCB damaged/Poor welding/Curl	PCB (Circuit area) damaged Not Allow, PCB Poor welding Not Allow PCB Curl $\leq 1\%$	MI	Visual/Ruler	
12	Edge glue height/Edge glue bubble	Edge Adhesives $H \leq PS$ surface (Including protect film) Edge adhesives seep in $\leq 1/2$ Margin width, Length excluding Edge adhesives bubble; bubble width $\leq 1/2$ Margin width; Length $\leq 0.5\text{mm}$ , $n \leq 5$	MI		Zone B
13	Protect film	Surface scratch but not effect protect function, Allowed	MI	Visual Inspection	
14	Silicon glue	Thickness $\leq PS$ surface (with protect film); Full cover the IC; Shape: The width on FPC $\leq 0.5\text{mm}$ (Front); The width on the FPC $\leq 1.0\text{mm}$ (Back) Smooth surface. No obvious raised.	MI	Visual Inspection	
15	Warp degree (TFT substrate)	 <p><math>t \leq 2.5\text{mm}</math></p>	MI	Ruler	
16	Color difference in COM area (Silver point area)	Allowed		Visual Inspection	

## 13. HANDLING, SAFETY, AND ENVIRONMENT REQUIREMENTS

### WARNING

The display glass may break when it is dropped or bumped on a hard surface. Handle with care. Should the display break, do not touch the electrophoretic material. In case of contact with electrophoretic material, wash with water and soap.

### CAUTION

The display module should not be exposed to harmful gases, such as acid and alkali gases, which corrode electronic components. Disassembling the display module.

Disassembling the display module can cause permanent damage and invalidates the warranty agreements.

Observe general precautions that are common to handling delicate electronic components. The glass can break and front surfaces can easily be damaged. Moreover the display is sensitive to static electricity and other rough environmental conditions.

<b>Data sheet status</b>	
Product specification	This data sheet contains final product specifications.
<b>Limiting values</b>	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
<b>Application information</b>	
Where application information is given, it is advisory and does not form part of the specification.	

## 14. PRECAUTIONS

- (1) Do not apply pressure to the EPD panel in order to prevent damaging it.
- (2) Do not connect or disconnect the interface connector while the EPD panel is in operation.
- (3) Do not touch IC bonding area. It may scratch TFT lead or damage IC function.
- (4) Please be mindful of moisture to avoid its penetration into the EPD panel, which may cause damage during operation.
- (5) If the EPD Panel / Module is not refreshed every 24 hours, a phenomena known as “Ghosting” or “Image Sticking” may occur. It is recommended to refreshed the ESL/EPD Tag every 24 hours in use case. It is recommended that customer ships or stores the ESL/EPD Tag with a completely white image to avoid this issue.
- (6) High temperature, high humidity, sunlight or fluorescent light may degrade the EPD panel’s performance. Please do not expose the unprotected EPD panel to high temperature, high humidity, sunlight, or fluorescent for long periods of time.